## Applicant(s)/Patent Under Application/Control No. Reexamination 10/649,050 CHEN ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 2825 Chuong A. Luu **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-6,737,320 05-2004 438/257 Α Chen et al. US-В С US-US-D Ε US-F US-G US-Н US-US-1 US-J Κ US-L US-М US-**FOREIGN PATENT DOCUMENTS Document Number** Date Classification Country Name Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

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